EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	242	(714/24).CCLS.	US-PGPUB; USPAT; USOCR	OR .	OFF	2007/03/27 19:53
L4	. 107	bios same (power voltage) same (sav\$3 stor\$3 record\$3 writ\$3) near2 (state volitile parameters status image) and (DMA DMAC "direct memory access" "memory controller" "io controller" "io processor") same (sav\$3 stor\$3 record\$3 writ\$3)	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	ON	2007/03/27 20:05
L5	47	714/21.ccls. and power	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	ON	2007/03/27 20:28
L6	322	(714/22).CCLS.	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	ON	2007/03/27 20:35
L8	217	(714/15).CCLS. and power and (mark\$3 valid validat\$3 invalid invalidat\$3)	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR	ON	2007/03/27 20:57
L9	5	((basic adj input adj output adj system BIOS) and (reset\$3 restart\$3 reboot\$3) and (state image) and (valid invalid) and (resum\$3 restart\$3 wake waked waking reboot\$3)).clm.	US-PGPUB	OR ·	ON	2007/03/27 21:25
L10	234	713/300,340.ccls. and (save saved saving record\$3) near3 (state image)	US-PGPUB	OR	ON	2007/03/27 21:41
L12	168	713/300.ccls. and (save saved saving record\$3) near3 (state image) and (BIOS basic adj input?output adj system)	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR .	ON	2007/03/27 21:46
L13	89	suspend adj2 memory and power and (reset restore resume)	US-PGPUB; USPAT; EPO; JPO; IBM_TDB	OR .	ON	2007/03/27 22:22



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Edit an existing query or compose a new query in the Search Query Display.

Select a search number (#)

- Add a query to the Search Query Display
- Combine search queries using AND, OR, or NOT
- Delete a search
- Run a search

Tue, 27 Mar 2007, 10:27:57 PM EST

Search Query Display

Recent Search Queries

((power and (state or image) and (restore or reboot or resume or reset) and (bios or ~~basic input output system~~))
<in>metadata)

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